MOSFET – Power, Single N-Channel 40 V, 4.5 m Ω , 80 A

NVMFS5C456N

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS5C456NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| | | | , | | |
|--|-------------------------------------|------------------------|-----------------------------------|-----------------|------|
| Parameter | | | Symbol | Value | Unit |
| Drain-to-Source Voltage | | | V_{DSS} | 40 | V |
| Gate-to-Source Voltage | Э | | V_{GS} | ±20 | V |
| Continuous Drain | | T _C = 25°C | I _D | 80 | Α |
| Current R _{θJC} (Notes 1, 3) | Steady | T _C = 100°C | | 56 | |
| Power Dissipation | State | T _C = 25°C | P_{D} | 55 | W |
| R _{θJC} (Note 1) | | T _C = 100°C | | 27 | |
| Continuous Drain | | T _A = 25°C | I _D | 20 | Α |
| Current R _{0JA} (Notes 1, 2, 3) | Steady | T _A = 100°C | | 14 | |
| Power Dissipation | State | T _A = 25°C | P_{D} | 3.6 | W |
| R _{θJA} (Notes 1 & 2) | | T _A = 100°C | | 1.8 | |
| Pulsed Drain Current | $T_A = 25^{\circ}C, t_p = 10 \mu s$ | | I _{DM} | 400 | Α |
| Operating Junction and Storage Temperature | | | T _J , T _{stg} | –55 to + 175 | °C |
| Source Current (Body Diode) | | | I _S | 45.5 | Α |
| Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 5.22 A) | | | E _{AS} | 239 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | TL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State | $R_{\theta JC}$ | 2.7 | °C/W |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 42 | |

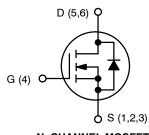
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



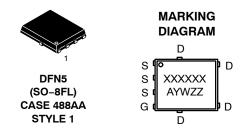
ON Semiconductor®

www.onsemi.com

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 40 V | 4.5 m Ω @ 10 V | 80 A |



N-CHANNEL MOSFET



XXXXXX = 5C456N

(NVMFS5C456N) or

456NWF

(NVMFS5C456NWF)

A = Assembly Location
Y = Year

W = Work Week

ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|-------------------------------------|--|------------------------|-----|------|-----|---------|
| OFF CHARACTERISTICS | | | | | • | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I_{D} = 250 μA | | 40 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / | | | | 23 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, T _J = 25 °C | | | | 10 | |
| | | $V_{DS} = 40 \text{ V}$ | T _J = 125°C | | | 250 | μΑ |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} = 20 V | | | | 100 | nA |
| ON CHARACTERISTICS (Note 4) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = 250 μA | 2.5 | | 3.5 | V |
| Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -6.5 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 35 A | | 3.8 | 4.5 | mV/°C |
| Forward Transconductance | 9 _{FS} | V _{DS} =15 V, I _D | = 35 A | | 57 | | S |
| CHARGES, CAPACITANCES & GATE RE | SISTANCE | | | | | | |
| Input Capacitance | C _{ISS} | $V_{GS} = 0 \text{ V, f} = 1 \text{ MHz, V}_{DS} = 25 \text{ V}$ | | | 1150 | | |
| Output Capacitance | C _{OSS} | | | | 600 | | pF |
| Reverse Transfer Capacitance | C _{RSS} | | | | 25 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 32 V; I _D = 35 A | | | 18 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | | | | 3.7 | | |
| Gate-to-Source Charge | Q _{GS} | | | | 5.7 | | |
| Gate-to-Drain Charge | Q_{GD} | | | | 3.0 | | |
| Plateau Voltage | V _{GP} | | | | 4.5 | | V |
| SWITCHING CHARACTERISTICS (Note 5 |) | | | | | | |
| Turn-On Delay Time | t _{d(ON)} | | | | 12 | | |
| Rise Time | t _r | V _{GS} = 10 V, V _{DS} | s = 32 V, | | 80 | | 1 _ |
| Turn-Off Delay Time | t _{d(OFF)} | V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 35 A, R_{G} = 1 Ω | | | 26 | | ns - |
| Fall Time | t _f | | | | 8 | | |
| DRAIN-SOURCE DIODE CHARACTERIS | TICS | | | | | | |
| Forward Diode Voltage | V_{SD} | V _{GS} = 0 V, | $T_J = 25^{\circ}C$ | | 0.82 | 1.2 | |
| | | I _S = 35 A | T _J = 125°C | | 0.69 | | V |
| Reverse Recovery Time | t _{RR} | $V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 35 \text{ A}$ | | | 33 | | |
| Charge Time | ta | | | | 16 | | ns |
| Discharge Time | t _b | | | | 17 | | 1 |
| Reverse Recovery Charge | Q _{RR} | | | | 18 | | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

^{5.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

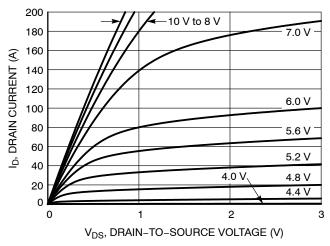


Figure 1. On-Region Characteristics

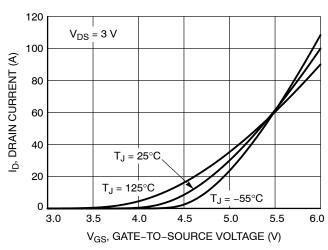


Figure 2. Transfer Characteristics

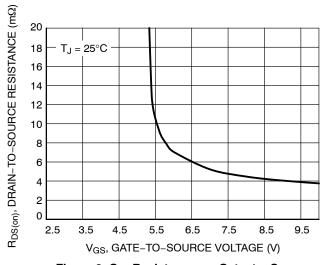


Figure 3. On-Resistance vs. Gate-to-Source Voltage

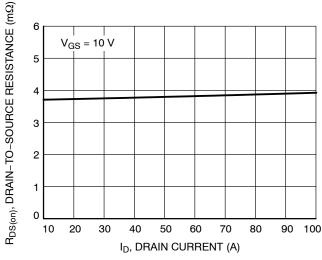


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

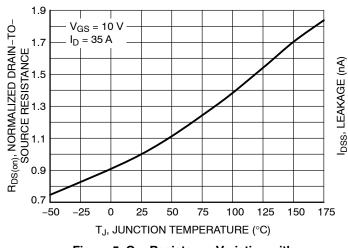


Figure 5. On–Resistance Variation with Temperature

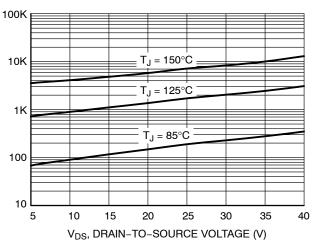


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

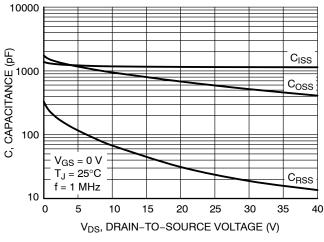


Figure 7. Capacitance Variation

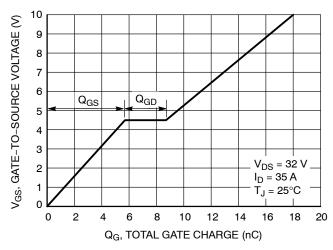
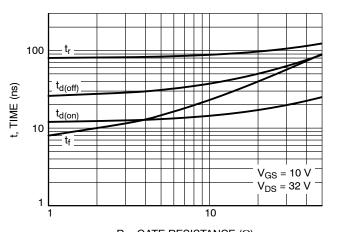


Figure 8. Gate-to-Source Voltage vs. Total Charge



 R_G , GATE RESISTANCE (Ω)

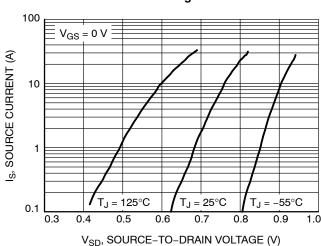


Figure 10. Diode Forward Voltage vs. Current



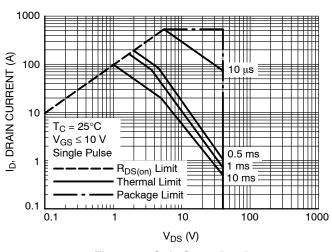


Figure 11. Safe Operating Area

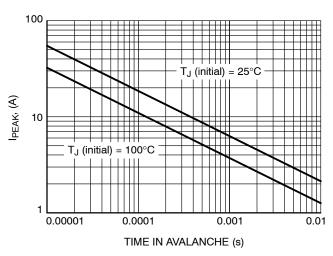


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

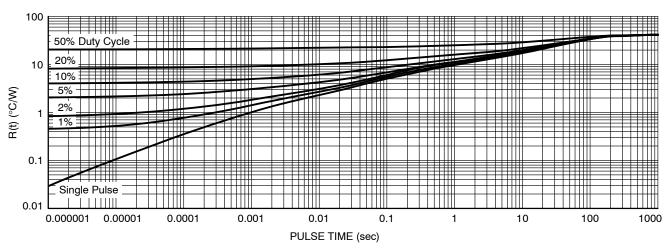


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|------------------|---------|------------------------------------|-----------------------|
| NVMFS5C456NT1G | 5C456N | DFN5 (Pb-Free) | 1500 / Tape & Reel |
| NVMFS5C456NWFT1G | 456NWF | DFN5 (Pb-Free, Wettable Flanks) | 1500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

| | MILLIMETERS | | | |
|-----|-------------|-------|------|--|
| DIM | MIN | NOM | MAX | |
| Α | 0.90 | 1.00 | 1.10 | |
| A1 | 0.00 | | 0.05 | |
| b | 0.33 | 0.41 | 0.51 | |
| С | 0.23 | 0.28 | 0.33 | |
| D | 5.00 | 5.15 | 5.30 | |
| D1 | 4.70 | 4.90 | 5.10 | |
| D2 | 3.80 | 4.00 | 4.20 | |
| E | 6.00 | 6.15 | 6.30 | |
| E1 | 5.70 | 5.90 | 6.10 | |
| E2 | 3.45 | 3.65 | 3.85 | |
| е | 1.27 BSC | | | |
| G | 0.51 | 0.575 | 0.71 | |
| K | 1.20 | 1.35 | 1.50 | |
| L | 0.51 | 0.575 | 0.71 | |
| L1 | 0.125 REF | | | |
| M | 3.00 | 3.40 | 3.80 | |
| A | 0 0 | | 12 ° | |

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

| DOCUMENT NUMBER: | 98AON14036D | Electronic versions are uncontrolled except when accessed directly from the Document Repository Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. | | |
|------------------|--------------------------|--|-------------|--|
| DESCRIPTION: | DFN5 5x6, 1.27P (SO-8FL) | | PAGE 1 OF 1 | |

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ÓN Semiconductor does not convey any license under its patent rights nor the rights of others

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative